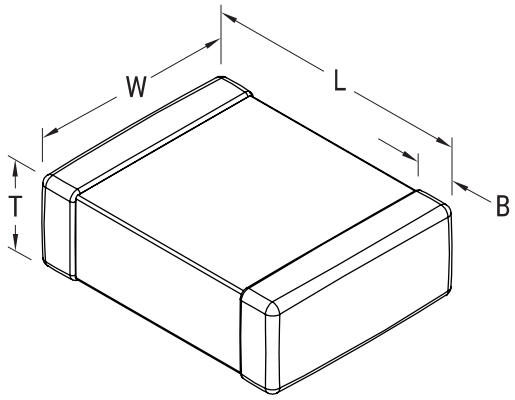
# KEMET Part Number: C1825C154KBRACTU

(C1825C154KBRAC7800)

SMD Comm X7R HV, Ceramic, 0.15 uF, 10%, 630 VDC, X7R, SMD, MLCC, High Voltage, Temperature Stable, 1825




| General Information | |
|---|---|
| **Series:** | SMD Comm X7R HV |
| **Style:** | SMD Chip |
| **Description:** | SMD, MLCC, High Voltage, Temperature Stable |
| **Features:** | High Voltage |
| **RoHS:** | Yes |
| **Termination:** | Tin |
| **Marking:** | No |
| **AEC-Q200:** | No |
| **Component Weight:** | 240 mg |
| **Shelf Life:** | 78 Weeks |
| **MSL:** | 1 |

| Dimensions | |
|---|---|
| **Chip Size** | 1825 |
| **L** | 4.5mm +/-0.3mm |
| **W** | 6.4mm +/-0.4mm |
| **T** | 1.4mm +/-0.15mm |
| **B** | 0.6mm +/-0.35mm |

| Specifications | |
|---|---|
| **Capacitance:** | 0.15 uF |
| **Measurement Condition:** | 1 kHz 1.0Vrms |
| **Capacitance Tolerance:** | 10% |
| **Voltage DC:** | 630 VDC |
| **Dielectric Withstanding Voltage:** | 945 VDC |
| **Temperature Range:** | -55/+125°C |
| **Temperature Coefficient:** | X7R |
| **Capacitance Change with Reference to +25°C and 0 VDC Applied (TCC):** | 15%, 1kHz 1.0Vrms |
| **Dissipation Factor:** | 2.5% 1 kHz 1.0Vrms |
| **Aging Rate:** | 3% Loss/Decade Hour: Referee Time is 1000 Hours |
| **Insulation Resistance:** | 666.7 MOhms |

| Packaging Specifications | |
|---|---|
| **Packaging:** | T&R, 180mm, Plastic Tape |
| **Packaging Quantity:** | 1000 |

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